ON-DETECTOR ELECTRONICS OF THE CLEAR PEM SCANNER


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Abstract: A Portuguese consortium has developed a PET scanner dedicated to breast cancer detection (Clear-PEM scanner) within the framework of the international Crystal Clear Collaboration at CERN. In the construction of this scanner several challenges have been addressed, from the design of the photon’s detector, front-end electronics and data acquisition systems up to the image reconstruction algorithms. In this paper we describe the development of the electronics in the detector heads needed to read-out and filter the data from 12288 detector channels, as well as to provide regulated high-voltages, low voltage power and control signals, and also to monitor the environment in the detector heads. The scanner is currently in its final phase of integration and will soon be installed in the department of Nuclear Medicine of Hospital Garcia de Orta and Instituto Português de Oncologia (Porto) were clinical trials will be conducted.

1 INTRODUCTION

The Clear-PEM detector is a Positron Emission Mammography scanner that was developed by several Portuguese institutions within the framework of the international Crystal Clear Collaboration at CERN (Abreu, 2006).

The detector assembly is based on two detecting planar heads. The detection heads are mounted on a robotized mechanical system, enabling the exam of both breasts, one at a time, as well as the axillary lymph nodes.

The basic element of the scanner is the detector module (Fig. 1). Each module has 32 LYSO:Ce crystals with 2x2x20 mm³ assembled in a matrix coupled on both ends to avalanche photo-diodes (APD) (Amaral, 2007). Twelve of these detector modules are assembled in a mechanical structure placed between two Frontend boards forming a Supermodule (Fig. 2).
The traditional readout based on photomultipliers is replaced by multi-pixel APDs. Due to its compactness, it is possible to read each single crystal with one APD pixel on each end, and to use the relative amplitude of the two signals to estimate the longitudinal coordinate of the photon interaction.

The individual 1:1 crystal-APD pixel coupling leads to 12,288 detector channels, with a density at about 13 channels per centimeter square. The limited available space in the detector heads demand that all the processing electronics must have a strict limited power consumption budget. This and the low gain (100) of the APDs, has lead to the development, for the Clear-PEM scanner, of specifically tailored low-noise Application-Specific Integrated Circuit (ASIC).

Frontend electronics boards based on the Clear-PEM ASICs provide the first level of signal processing, including readout, amplification, sampling and storage in analogue memories of the APD array signals.

The ASIC’s output pulses are digitized by free-sampling ADCs in the Frontend boards. LVDS data links are used to transmit the detector data to the off-detector electronics system, which implements the first-level trigger, and data concentration and transmission to the data acquisition server (Albuquerque, 2008).

Auxiliary service boards located in the detector heads are needed to provide regulated high-voltages for each of the APD arrays and to distribute low voltage power as well as control and clock signals. The electronics is also responsible to monitor the detector heads environment (temperature and pressure).

Each Clear-PEM detector head has a total 3072 crystals grouped in 96 detector modules and 8 Supermodules. The detector head includes also one Service Board, one high-voltage connection Matrix Board and one clock fan-out unit. These electronics boards are described in the following sections.

2 THE FRONT END ELECTRONICS SYSTEM

The Frontend electronics system is one of the most challenging and innovative sub-systems of the Clear-PEM detector. It is composed by the Frontend boards which interface directly with the APD arrays assembled in the detector modules and are connected to the Auxiliary Boards in the detector head.

The system, physically located on the detector heads, performs signal amplification, channel selection and analog multiplexing, analog to digital conversion and parallel-to-serial translation.

A frontend ASIC has been developed for readout of the multi-pixel S8550 Hamamatsu APDs. Themixed-signal ASIC incorporates 192 low-noise charge pre-amplifiers, shapers, analogue memory cells and digital control blocks. Pulses are continuously stored in memory cells at clock frequency. Channels above a common threshold voltage are readout for digitization by off-chip free sampling ADCs. The number of output channels of the frontend ASIC is two, still allowing for the readout of two-hit Compton interactions in the detector. The ASIC has a size of 7.3 mm x 9.8 mm and was designed in 0.35 μm CMOS technology.

The Frontend Board (FEB) integrates two 192 channels ASICs and two dual free-sampling 10-bit ADC chips working at frequencies up to 100 MHz. The digitized data is transmitted to the off-detector data acquisition system by LVDS serial links at 600 MHz.

Two FEBs are used to mount one supermodule structure with a total of 768 electronic channels and dimensions of 12x4.5 cm² as illustrated in Fig. 2.

The frontend electronics must have low-noise due to the initial reduced charge at the amplifier input, which for a 511 keV photon energy deposit is around 30fC (maximum value). The frontend ASIC amplifies this charge by about three orders of magnitude, while complying with the low-power dissipation requirements (5 mW/channel), compatible with a compact water based cooling system that allows to operate the detector at 18°C. A temperature stability of the order of 0.1 °C is required since the LYSO:Ce light yield and APD
gain are inversely dependent on the temperature (2-3%/°C).

The Frontend Boards have a mixed analog-digital environment and therefore special care is needed regarding the correct conditioning of the digital, large amplitude, high-frequency clock and other periodic signals. Noise pickup in the PCB traces that connect the APD outputs to the frontend chips must also be minimized.

The performance of the Supermodules was evaluated in a setup that integrates all the electronics and data acquisition sub-systems as it will operate in the final detector. A cooling system based on controlled flux of cold water was build to cope with the power dissipation from the Frontend Boards during the qualification tests.

Acquisition runs with $^{22}$Na and $^{137}$Cs radioactive sources, as well as background acquisitions from the $^{176}$Lu natural radioactivity of the LYSO:Ce crystals have been performed (R. Bugalho, 2008).

The energy and time resolutions, energy linearity of detector readout chain and output channels occupancy are the parameters under evaluation for each supermodule.

The noise of the detector channels, defined as the equivalent noise charge (ENC) at the amplifier inputs, is around 1300 e$^-$ RMS. This noise contributes less than 2% to the energy resolution, which at 511 keV is dominated by the fluctuations of the scintillating light signal in the crystals. This noise level implies a RMS time resolution of individual 511 keV photons of the order of 1 ns.

3 THE AUXILIARY BOARDS

Several auxiliary boards have been designed to provide regulated high-voltages, low voltage power, as well as clock and control signals to the Supermodules, and also to monitor the temperature and pressure inside the detector heads.

These boards are placed in the back side of the detector head, leaving the front side free of obstacles for the detection of the PET photons.

The main auxiliary board is the Service Board (SB) shown in figure 3.

Dedicated circuits in the SB including remotely controlled Digital to Analog Converters (DAC) are used to regulate the high-voltage (HV) lines (350-500V) needed for the polarization of the APDs. Plugging directly on the SB, the HV Matrix is another auxiliary board that provides the connections of the HV lines to the APD arrays (figure 4).

The connection matrix distributes 32 different high-voltage references to the 384 APDs sub-arrays (16 pixels) in the detector head. The APD gain variation is of the order of 6%/V which requires a stability of the biasing voltages better that 0.1 V. The ripple of the high-voltage lines is less than 0.02 V. Before assembly each HV channel is calibrated in order to guarantee that the gain of the APDs is 100.

External power supplies provide independent low-voltages for the analog and digital sections of the detector electronics. The SB organizes the distribution of these voltages to the Frontend Boards.

The control of the ASICs reset sequence uses an Altera FPGA in the Service Board, and the setting of the voltage thresholds of signal detection in the ASICs is done by DACs controlled remotely via I2C.

The measurement of the temperature in the detector modules uses PT100 sensors placed in contact with the APD arrays, coupled to dedicated signal conditioning circuits followed by ADCs accessed remotely by the I2C control lines. The pressure inside the detector head is also measured to assure that slightly over-pressured nitrogen fills the detector heads avoiding water condensation.

The system clock and a synchronization signal are distributed to the frontend electronics. To avoid interferences of the clock with the high-voltage lines, a dedicated board is used to fan-out the clock and sync signals.

Finally the detector head are closed using a specifically designed patch panel board equipped with vacuum tight connectors to insure the detector box hermeticity (fig 4).
4 CONCLUSIONS

In this paper, the detector electronics of the Clear-PEM scanner, composed of the Frontend Boards connecting directly with the detector modules and of the Auxiliary Boards in the detector heads, was presented. The detector electronics system is one of the most challenging and innovative sub-systems of the Clear-PEM scanner.

This electronics was validated in an experimental setup that includes detector supermodules and all the external sub-systems developed for the Clear-PEM scanner, including the data acquisition electronics and computing systems. The measured electronic noise levels in the detector are below the requirements set by the Clear-PEM specifications.

REFERENCES


